Application/Control No.	Applicant(s)/Patent under Reexamination		
09/848,411	JESKE ET AL.		
Examiner	Art Unit		
Jason M. Perilla	2611		

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	316	9/27/2006	JP
	346	9/27/2006	JP
	146	9/27/2006	JP
	295-297	9/27/2006	JP
			_
		•	,

INT	ERFEREN	RFERENCE SEARCHED		
Class	Subclass	Date	Examiner	
375	316	9/27/2006	JP	
	346	9/27/2006	JP	
	146	9/27/2006	JP	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE .	EXMR
East USPAT/USPGPUB EPO/JPO		9/27/2006	JP
Inventor Name Search EAST/EDAN		9/27/2006	JP